


<b>Search Notes</b>  	<b>Application/Control No.</b>  10829142	<b>Applicant(s)/Patent Under Reexamination</b>  TAKANO ET AL.
	<b>Examiner</b>  Whipkey, Jason T	<b>Art Unit</b>  2622

SEARCHED			
Class	Subclass	Date	Examiner
348	300	8/16/2007	JTW
348	207.99	8/17/2007	JTW
348	222.1	8/17/2007	JTW
348	267	8/17/2007	JTW
348	275	8/17/2007	JTW
348	279	8/17/2007	JTW
348	294	8/16/2007	JTW
348	302	8/17/2007	JTW
382	164	8/17/2007	JTW

SEARCH NOTES		
Search Notes	Date	Examiner
Inventors' names search in PALM	8/17/2007	JTW
Inventors' names search in EAST	8/17/2007	JTW
Text search (some searches restricted to specific subclasses)	8/16/2007	JTW

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	See interference search printout	8/17/2007	JTW